## **Application Data Sh et**

### **Application Information**

Application number:: Not Yet Assigned

Application Type:: Regular

Subject Matter:: Utility

Suggested Group Art Unit:: N/A

CD-ROM or CD-R?:: None

Sequence submission?:: None

Computer Readable Form (CRF)?:: No

Title:: TESTING APPARATUS AND METHOD FOR

TESTING THE CONTACTING BETWEEN A

SEMICONDUCTOR DEVICE AND A

**CARRIER** 

Attorney Docket Number:: 543822002400

Request for Early Publication?:: No

Request for Non-Publication?:: No

Small Entity?:: No

Petition included?:: No

Secrecy Order in Parent Appl.?:: No

#### **Applicant Information**

Applicant Authority Type:: Inventor

Primary Citizenship Country:: Germany

Status:: Full Capacity

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# **Corr spondence Information**

Correspondence Customer Number::

25227

# **Representative Information**

Representative Customer Number::

25227

## **Foreign Priority Information**

Country::	Application number::	Filing Date::	Priority Claimed::
Germany	10256692.5	December 4, 2002	Yes

### **Assignee Information**

Assignee name::

Infineon Technologies AG

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City of mailing address::

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